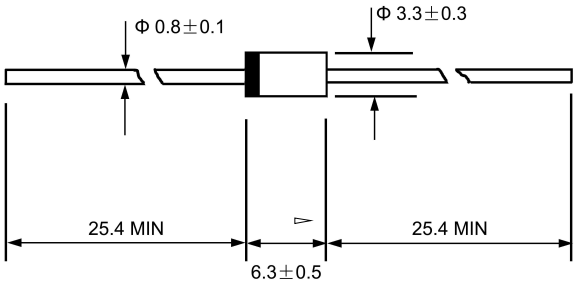
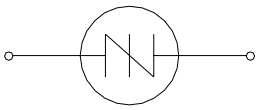
K1050G THRU K2501G

Bilateral Voltage triggered Switch Breakover Voltage:95-280Volts

DO - 15



Dimensions in millimeters



Features

- ◇ A sidac is a silicon bilateral voltage triggered switch, with greater power-handling capabilities than standard diacs. Upon application of a voltage exceeding the Sidac breakover voltage point, the Sidac switches on, through a negative resistance region, to a a low on-state voltage. Conduction will continue until the current is interrupte or drops below the minimum holding current of the device.
- ◇ Switching voltages in the range of 95 V to 330 V.
- ◇ Sidacs feature glass-passivated junctions that ensure long term reliability and stable characteristics by creating a rugged, reliable barrier against junction contamination.
- ◇ Variations of devices covered in this data sheet are available for custom design applications. Please consult the factory for more information.

Type	$I_{T(RMS)}$	V_{DRM}	V_{BO}		I_{DRM}	I_{BO}	I_H		V_{TM}	I_{TSM}		R_S	dv/dt	di/dt
	(7) (8)		(1)				(3) (4)			(5)		(9)		
	A	V	V		μA	μA	mA		V	A		kΩ	V/μSec	A/μSec
	MAX	MIN	MIN	MAX	MAX	MAX	TYP	MAX	Max	60Hz	50Hz	MIN	MIN	TYP
K1050G	1	±90	95	113	5	10	60	150	1.5	20	16.7	0.1	1500	150
K1100G	1	±90	104	118	5	10	60	150	1.5	20	16.7	0.1	1500	150
K1200G	1	±90	110	125	5	10	60	150	1.5	20	16.7	0.1	1500	150
K1300G	1	±90	120	138	5	10	60	150	1.5	20	16.7	0.1	1500	150
K1400G	1	±90	130	146	5	10	60	150	1.5	20	16.7	0.1	1500	150
K1500G	1	±90	140	170	5	10	60	150	1.5	20	16.7	0.1	1500	150
K2000G	1	±180	190	215	5	10	60	150	1.5	20	16.7	0.1	1500	150
K2200G	1	±180	205	230	5	10	60	150	1.5	20	16.7	0.1	1500	150
K2400G	1	±190	220	250	5	10	60	150	1.5	20	16.7	0.1	1500	150
K2500G	1	±200	240	280	5	10	60	150	1.5	20	16.7	0.1	1500	150
K2501G	1(10)	±200	240	280	5	75	60	150	6	20	16.7	0.1	1500	150

V-I CHARACTERISTICS

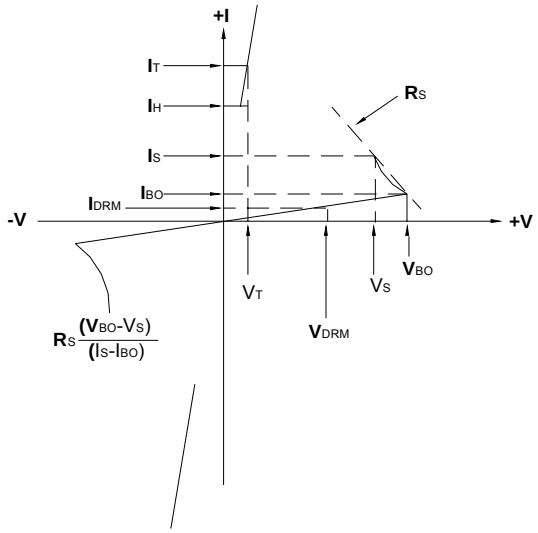
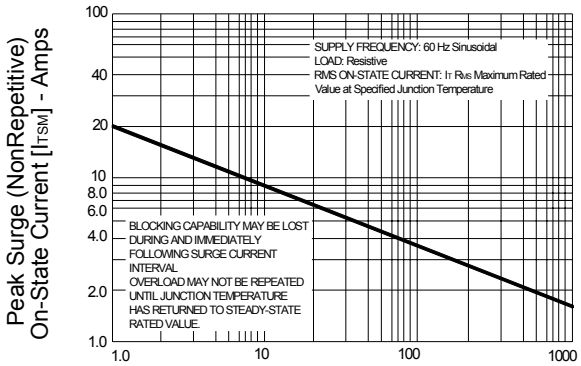


FIG.1-- PEAK SURGE CURRENT vs SURGE CURRENT DURATION



Surge Current Duration - Full Cycles

Specific Test Conditions

di/dt — Critical rate-of-rise of on-state current

dv/dt — Critical rate-of-rise of off-state voltage at rated V_{DRM}; $T_J \leq$ 100°C

I_{BO} — Breakover current 50/60 Hz sine wave

I_{DRM} — Repetitive peak off-state current 50/60 Hz sine wave; V = V_{DRM}

I_H — Dynamic holding current 50/60 Hz sine wave; R = 100 Ω

$I_{T(RMS)}$ — On-state RMS current $T_J \leq$ 125°C 50/60 Hz sine wave

I_{TSM} — Peak one cycle surge current 50/60 Hz sine wave (nonrepetitive)

R_S — Switching resistance $R_S = \frac{(V_{BO}-V_S)}{(I_S-I_{BO})}$ 50/60 Hz sine wave

V_{BO} — Breakover voltage 50/60 Hz sine wave

V_{DRM} — Repetitive peak off-state voltage

V_{TM} — Peak on-state voltage, I_T = 1 Amp

General Notes

◇ All measurements are made at 60Hz with a resistive load at an ambient temperature of +25°C unless otherwise specified.

◇ Storage temperature range (T_S) is -65°C to +150°C.

◇ The case (T_C) or lead (T_L) temperature is measured as shown on the dimensional outline drawings. See “Package Dimensions” section of this catalog.

◇ Junction temperature range (T_J) is -40°C to +125°C.

◇ Lead solder temperature is a maximum of +230°C for 10 seconds maximum; ≥ 1/16" (1.59mm) from case.

Electrical Specification Notes

(1) See Figure 9.5 for V_{BO} change vs junction temperature.

(2) See Figure 9.6 for IBO vs junction temperature.

(3) See Figure 9.2 for I_H vs case temperature.

(4) See Figure 9.13 for test circuit.

(5) See Figure 9.1 for more than one full cycle rating.

(6) $R_{\theta JA}$ Type 41 is 70° C/W.

(7) $T_L \leq$ 100°C

(8) See Figure 9.14 for clarification of Sidac operation.

(9) For best Sidac operation, the load impedance should be near or less than switching resistance.

FIG.2 -- NORMALIZED DC HOLDING CURRENT vs CASE/LEAD TEMPERATURE

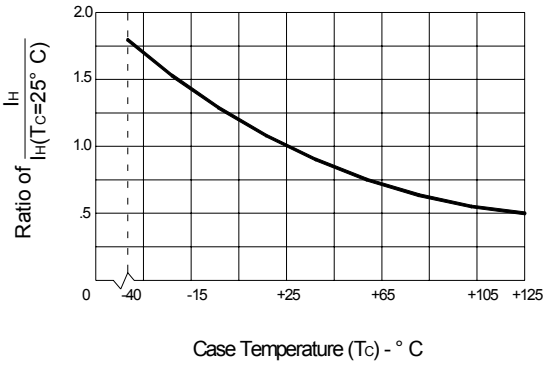


FIG.3-- REPETITIVE PEAK ON-STATE CURRENT (I_{TRM}) vs PULSE WIDTH at VARIOUS FREQUENCIES

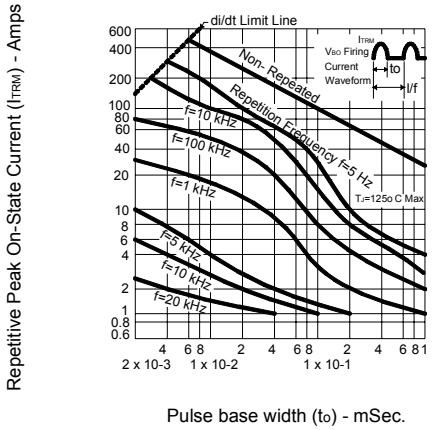


FIG.4 -- MAXIMUM ALLOWABLE AMBIENT TEMPERATURE vs ON-STATE CURRENT

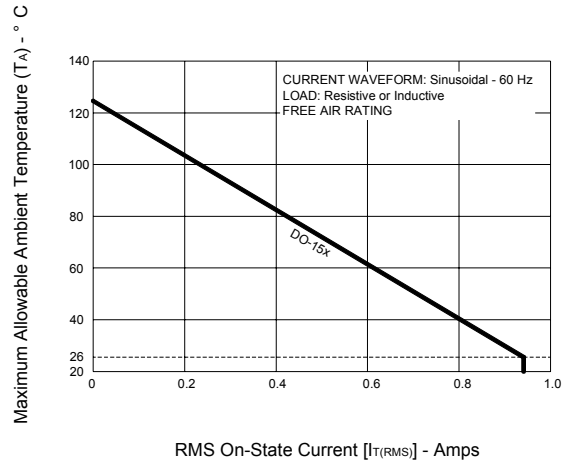


FIG.5 -- NORMALIZED V_{BO} CHANGE vs JUNCTION TEMPERATURE

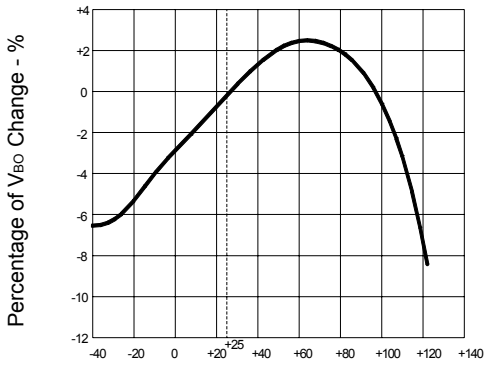


FIG.6 -- NORMALIZED REPETITIVE PEAK BREAKOVER CURRENT vs JUNCTION TEMPERATURE

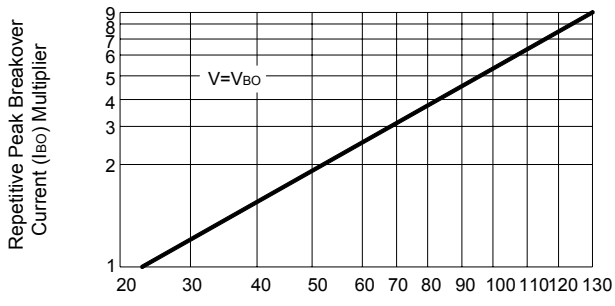


FIG.7 -- ON-STATE CURRENT vs ON-STATE VOLTAGE (TYPICAL)

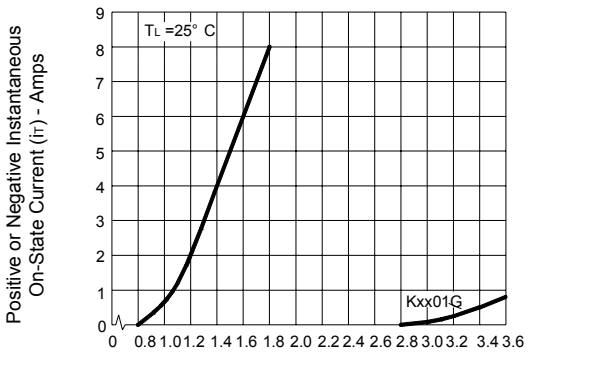


FIG.8 -- POWER DISSIPATION (TYPICAL) vs ON-STATE CURRENT

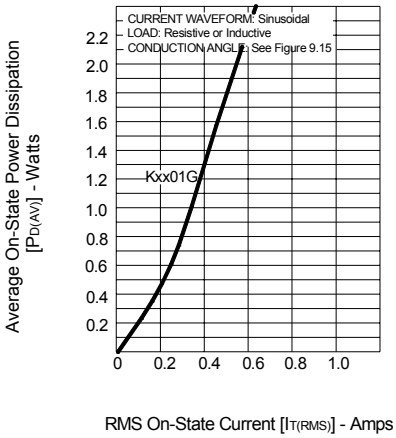


FIG.9 -- COMPARISON OF SIDAC vs SCR

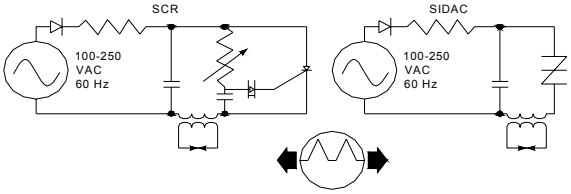


FIG.10 -- LGNITOR CIRCUIT (LOW VOLTAGE INPUT)

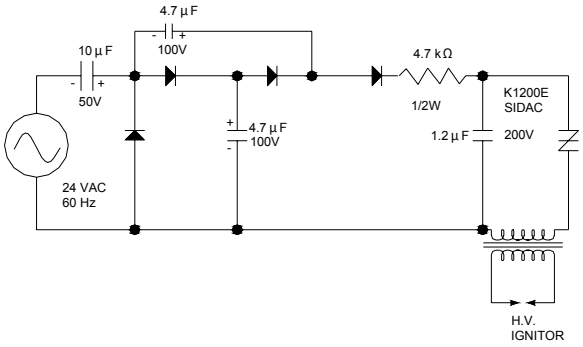


FIG.11 -- TYPICAL HIGH PRESSURE SODIUM LAMP FIRING CIRCUIT

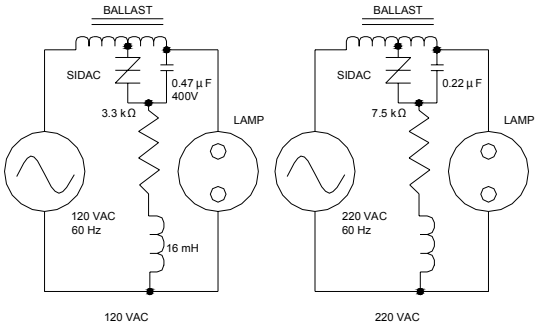


FIG.12 -- XENON LAMP FLASHING CIRCUIT

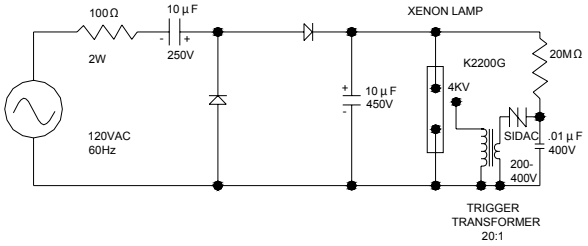


FIG.13 -- DYNAMIC HOLDING CURRENT TEST CIRCUIT FOR SIDACS

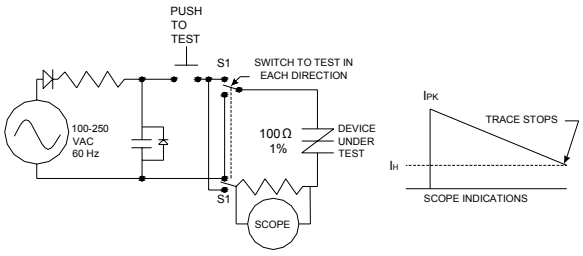


FIG.14 -- BASIC SIDAC CIRCUIT

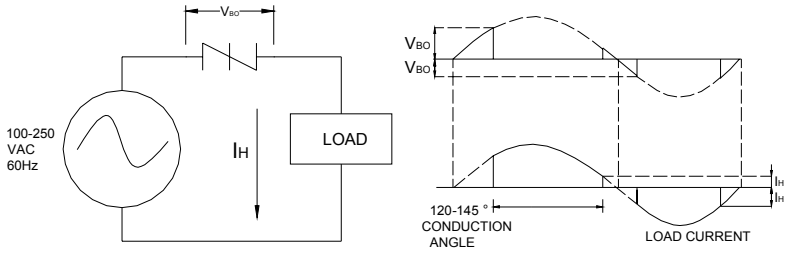


FIG.15 -- RELAXATION OSCILLATOR USING a SIDAC

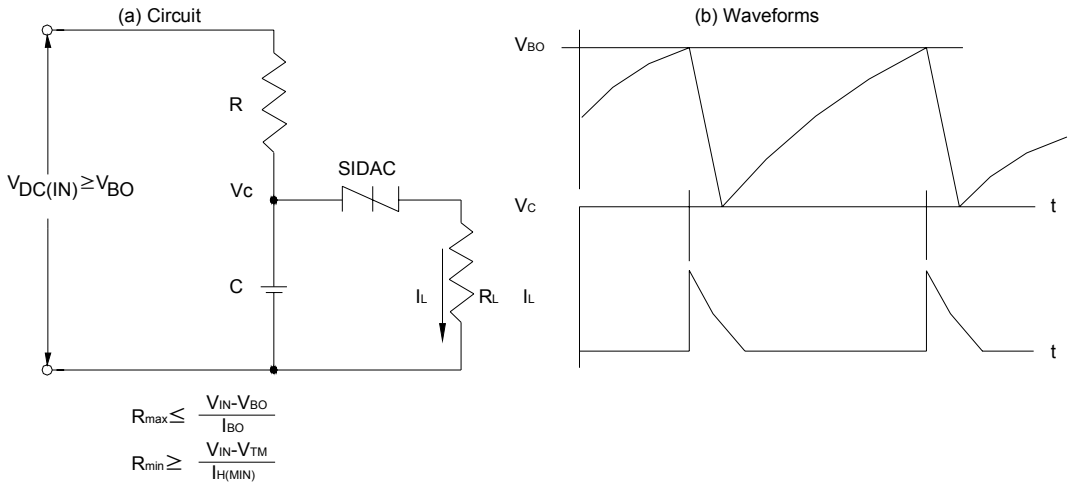
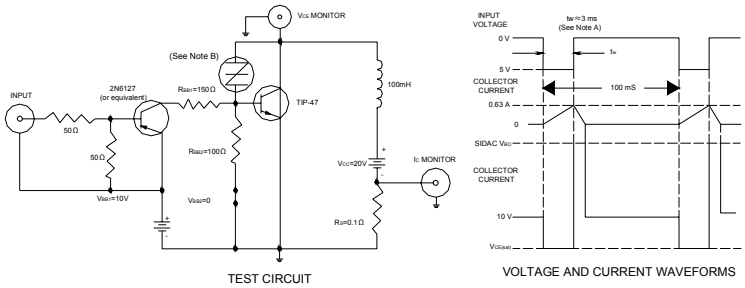


FIG.16 -- SIDAC ADDED TO PROTECT TRANSISTOR FOR TYPICAL TRANSISTOR INDUCTIVE LOAD SWITCHING REQUIREMENTS



NOTE A: Input pulse width is increased until I_{CM} = 0.63A.
NOTE B: Sidac (or Diac or series of Diacs) chosen so that V_{BO} is just below V_{CEO} rating of transistor to be protected. The Sidac (or Diac) eliminates a reverse breakdown of the transistor in inductive switching circuits where otherwise the transistor could be destroyed.